Ignition IGBT

20 Amp, 350 Volt, N-Channel DPAK

This Logic Level Insulated Gate Bipolar Transistor (IGBT) features monolithic circuitry integrating ESD and Overvoltage clamped protection for use in inductive coil drivers applications. Primary uses include Ignition, Direct Fuel Injection, or wherever high voltage and high current switching is required.

Features

- Ideal for Coil-on-Plug and Driver-on-Coil Applications
- DPAK Package Offers Smaller Footprint for Increased Board Space
- Gate-Emitter ESD Protection
- Temperature Compensated Gate-Collector Voltage Clamp Limits Stress Applied to Load
- Integrated ESD Diode Protection
- Low Threshold Voltage for Interfacing Power Loads to Logic or Microprocessor Devices
- Low Saturation Voltage
- High Pulsed Current Capability
- Optional Gate Resistor (R_G) and Gate-Emitter Resistor (R_{GE})
- These are Pb-Free Devices

Applications

• Ignition Systems

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V _{CES}	390	V
Collector-Gate Voltage	V _{CER}	390	V
Gate-Emitter Voltage	V _{GE}	±15	V
Collector Current–Continuous @ T _C = 25°C – Pulsed	I _C	20 50	A _{DC} A _{AC}
Continuous Gate Current	IG	1.0	mA
Transient Gate Current (t≤2 ms, f≤100 Hz)	IG	20	mA
ESD (Charged-Device Model)	ESD	2.0	kV
ESD (Human Body Model) R = 1500 Ω , C = 100 pF	ESD	8.0	kV
ESD (Machine Model) R = 0 Ω , C = 200 pF	ESD	400	V
Total Power Dissipation @ T _C = 25°C Derate above 25°C	P _D	125 0.83	W/°C
Operating & Storage Temperature Range	T _J , T _{stg}	-55 to +175	°C

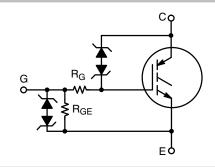
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



ON Semiconductor®

http://onsemi.com

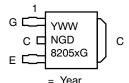
20 A, 350 V $V_{CE(on)} = 1.3 V @ I_C = 10 A, V_{GE} \ge 4.5 V$





DPAK CASE 369C STYLE 7

MARKING DIAGRAM



Y = Year WW = Work Week NGD8205x = Device Code x = N or A

G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NGD8205NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NGD8205ANT4G	DPAK (Pb-Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

UNCLAMPED COLLECTOR-TO-EMITTER AVALANCHE CHARACTERISTICS ($-55^{\circ} \le T_J \le 175^{\circ}C$)

Characteristic	Symbol	Value	Unit
Single Pulse Collector–to–Emitter Avalanche Energy $ \begin{array}{c} V_{CC} = 50 \text{ V}, V_{GE} = 5.0 \text{ V}, \text{ Pk I}_L = 16.7 \text{ A}, R_G = 1000 \Omega, L = 1.8 \text{ mH}, \text{ Starting } T_J = 25^{\circ}\text{C} \\ V_{CC} = 50 \text{ V}, V_{GE} = 5.0 \text{ V}, \text{ Pk I}_L = 14.9 \text{ A}, R_G = 1000 \Omega, L = 1.8 \text{ mH}, \text{ Starting } T_J = 150^{\circ}\text{C} \\ V_{CC} = 50 \text{ V}, V_{GE} = 5.0 \text{ V}, \text{ Pk I}_L = 14.1 \text{ A}, R_G = 1000 \Omega, L = 1.8 \text{ mH}, \text{ Starting } T_J = 175^{\circ}\text{C} \\ \end{array} $	E _{AS}	250 200 180	mJ
Reverse Avalanche Energy V_{CC} = 100 V, V_{GE} = 20 V, Pk I _L = 25.8 A, L = 6.0 mH, Starting T _J = 25°C	E _{AS(R)}	2000	mJ

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	1.2	°C/W
Thermal Resistance, Junction-to-Ambient (Note 1)	$R_{ hetaJA}$	95	°C/W
Maximum Temperature for Soldering Purposes, 1/8" from case for 5 seconds (Note 2)	TL	275	°C

ELECTRICAL CHARACTERISTICS

Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Collector-Emitter Clamp Voltage	BV _{CES}	I _C = 2.0 mA	$T_{J} = -40^{\circ}\text{C to } 175^{\circ}\text{C}$	325	350	375	V
		I _C = 10 mA	$T_{J} = -40^{\circ}\text{C to } 175^{\circ}\text{C}$	340	365	390	
Zero Gate Voltage Collector Current	I _{CES}	V _{GE} = 0 V, V _{CE} = 15 V	T _J = 25°C		0.1	1.0	μΑ
			T _J = 25°C	0.5	1.5	10	μΑ
		V _{CE} = 175 V, V _{GE} = 0 V	T _J = 175°C	1.0	25	100*	
		VGE - V	T _J = −40°C	0.4	0.8	5.0	
Reverse Collector-Emitter Clamp Voltage	B _{VCES(R)}		T _J = 25°C	30	35	39	V
		I _C = -75 mA	T _J = 175°C	35	39	45*	1
			T _J = -40°C	30	33	37	1
Reverse Collector-Emitter Leakage Current	I _{CES(R)}	V _{CE} = -24 V - NGD8205	T _J = 25°C	0.05	0.25	0.5	mA
			T _J = 175°C	1.0	12.5	25	1
			T _J = −40°C	0.005	0.03	0.25	1
			T _J = 25°C	0.05	0.25	1.0	1
		V _{CE} = -24 V - NGD8205A	T _J = 175°C	1.0	12.5	25	1
			T _J = -40°C		0.03	0.25	
Gate-Emitter Clamp Voltage	BV _{GES}	$I_G = \pm 5.0 \text{ mA}$	$T_{J} = -40^{\circ}\text{C to } 175^{\circ}\text{C}$	12	12.5	14	V
Gate-Emitter Leakage Current	I _{GES}	V _{GE} = ±5.0 V	$T_{J} = -40^{\circ}\text{C} \text{ to } 175^{\circ}\text{C}$	200	300	350*	μΑ
Gate Resistor (Optional)	R _G		$T_{J} = -40^{\circ}\text{C to } 175^{\circ}\text{C}$		70		Ω
Gate-Emitter Resistor	R _{GE}		$T_{J} = -40^{\circ}\text{C to } 175^{\circ}\text{C}$	14.25	16	25	kΩ
ON CHARACTERISTICS (Note 4)	•						
Gate Threshold Voltage	V _{GE(th)}		T _J = 25°C	1.5	1.8	2.1	V
		I _C = 1.0 mA, V _{GE} = V _{CE}	T _J = 175°C	0.7	1.0	1.3	
		I GE ICE	T _J = -40°C	1.7	2.0	2.3*	1
Threshold Temperature Coefficient (Negative)				3.8	4.6	6.0	mV/°C

^{*}Maximum Value of Characteristic across Temperature Range. 3. Pulse Test: Pulse Width \leq 300 μ S, Duty Cycle \leq 2%.

When surface mounted to an FR4 board using the minimum recommended pad size.
 For further details, see Soldering and Mounting Techniques Reference Manual: SOLDERRM/D.

ELECTRICAL CHARACTERISTICS

Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit
ON CHARACTERISTICS (Note 4)							
Collector-to-Emitter On-Voltage	V _{CE(on)}		T _J = 25°C	0.95	1.15	1.35	V
		I _C = 6.5 A, V _{GE} = 3.7 V	T _J = 175°C	0.7	0.95	1.15	
		I I I I I I I I I I I I I I I I I I I	$T_J = -40^{\circ}C$	1.0	1.3	1.40	1
			T _J = 25°C	0.95	1.25	1.45	1
		I _C = 9.0 A, V _{GF} = 3.9 V	T _J = 175°C	0.8	1.05	1.25	1
		I I I I I I I I I I I I I I I I I I I	$T_J = -40^{\circ}C$	1.1	1.4	1.5	1
			T _J = 25°C	0.85	1.15	1.4	1
		I _C = 7.5 A, V _{GE} = 4.5 V	T _J = 175°C	0.7	0.95	1.2	1
		VGE = 1.0 V	$T_J = -40^{\circ}C$	1.0	1.3	1.6*	
			T _J = 25°C	1.0	1.3	1.6	
		I _C = 10 A, V _{GE} = 4.5 V	T _J = 175°C	0.8	1.05	1.4	
		I I I I I I I I I I I I I I I I I I I	$T_J = -40^{\circ}C$	1.1	1.4	1.7*	
			T _J = 25°C	1.15	1.45	1.7	
		I _C = 15 A, V _{GE} = 4.5 V	T _J = 175°C	1.0	1.3	1.55	
		VGE = 1.0 V	T _J = −40°C	1.25	1.55	1.8*	
			T _J = 25°C	1.3	1.6	1.9	
		I _C = 20 A, V _{GE} = 4.5 V	T _J = 175°C	1.2	1.5	1.8	
		VGE = 1.0 V	T _J = −40°C	1.4	1.75	2.0*	
Forward Transconductance	gfs	I _C = 6.0 A, V _{CE} = 5.0 V	T _J = 25°C	10	18	25	Mhos
DYNAMIC CHARACTERISTICS		l l		l .	ļ	<u> </u>	
Input Capacitance	C _{ISS}			1100	1300	1500	pF
Output Capacitance	Coss	f = 10 kHz, V _{CE} = 25 V	T _J = 25°C	70	80	90	
Transfer Capacitance	C _{RSS}	-	0	18	20	22	1
SWITCHING CHARACTERISTICS	<u> </u>			I			
Turn-Off Delay Time (Resistive)	t _{d(off)}		T _J = 25°C	6.0	8.0	10	μSec
		V _{CC} = 300 V, I _C = 9.0 A	T _J = 175°C	6.0	8.0	10	
Fall Time (Resistive)	t _f	$R_G = 1.0 \text{ k}\Omega, R_L = 33 \Omega, V_{GE} = 5.0 \text{ V}$	T _J = 25°C	4.0	6.0	8.0	
			T _J = 175°C	8.0	10.5	14	
Turn-Off Delay Time (Inductive)	t _{d(off)}		T _J = 25°C	3.0	5.0	7.0	
, , ,		$V_{CC} = 300 \text{ V}, I_{C} = 9.0 \text{ A}$	T _J = 175°C	5.0	7.0	9.0	1
Fall Time (Inductive)	t _f	- R_G = 1.0 kΩ, L = 300 μH, V_{GE} = 5.0 V	T _J = 25°C	1.5	3.0	4.5	1
			T _J = 175°C	5.0	7.0	10	1
Turn-On Delay Time	t _{d(on)}		T _J = 25°C	1.0	1.5	2.0	1
,	,	$V_{CC} = 14 \text{ V, } I_{C} = 9.0 \text{ A}$	T _J = 175°C	1.0	1.5	2.0	1
Rise Time	t _r	- R _G = 1.0 kΩ, R _L = 1.5 Ω, V _{GE} = 5.0 V	T _J = 25°C	4.0	6.0	8.0	1
			T _J = 175°C	3.0	5.0	7.0	1

^{*}Maximum Value of Characteristic across Temperature Range. 4. Pulse Test: Pulse Width $\leq 300~\mu S$, Duty Cycle $\leq 2\%$.

TYPICAL ELECTRICAL CHARACTERISTICS

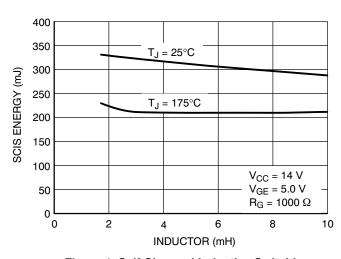


Figure 1. Self Clamped Inductive Switching

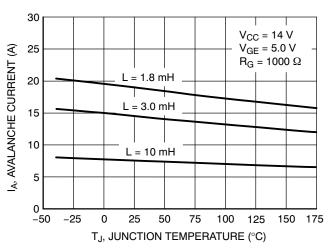


Figure 2. Open Secondary Avalanche Current vs. Temperature

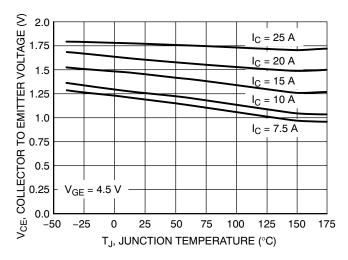


Figure 3. Collector-to-Emitter Voltage vs. Junction Temperature

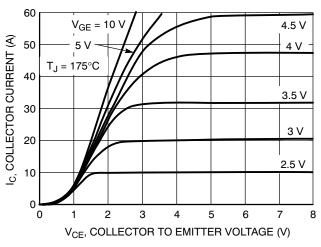


Figure 4. Collector Current vs. Collector-to-Emitter Voltage

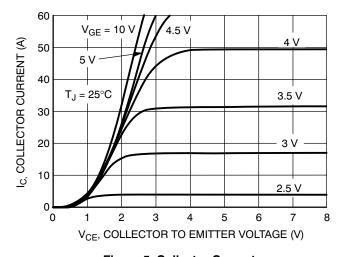


Figure 5. Collector Current vs. Collector-to-Emitter Voltage

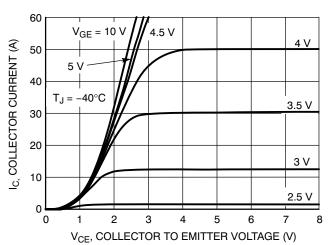


Figure 6. Collector Current vs. Collector-to-Emitter Voltage

TYPICAL ELECTRICAL CHARACTERISTICS

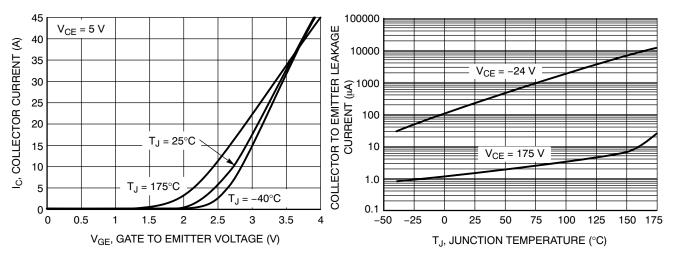


Figure 7. Transfer Characteristics

Figure 8. Collector-to-Emitter Leakage Current vs. Temperature

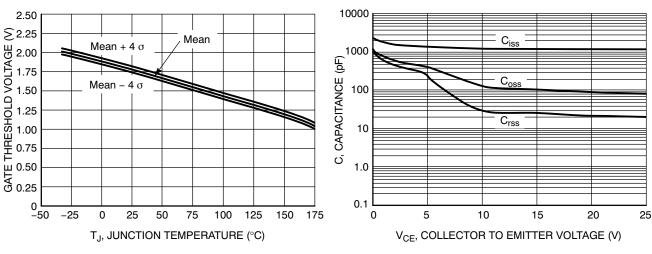


Figure 9. Gate Threshold Voltage vs. Temperature

12 10 t_{fall} SWITCHING TIME (µS) 8 6 V_{CC} = 300 V $V_{GE} = 5.0 \text{ V}$ $R_G = 1000 \Omega$ $I_{C} = 9.0 A$ 2 $R_I = 33 \Omega$ 0 | 25 50 100 150 175 T_J, JUNCTION TEMPERATURE (°C)

Figure 11. Resistive Switching Fall Time vs. Temperature

Figure 10. Capacitance vs. Collector-to-Emitter Voltage

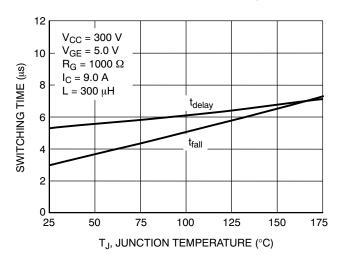


Figure 12. Inductive Switching Fall Time vs.
Temperature

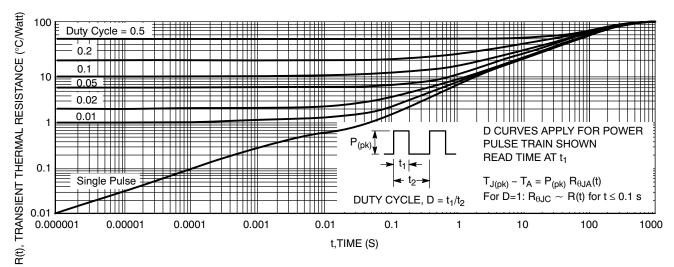


Figure 13. Minimum Pad Transient Thermal Resistance (Non-normalized Junction-to-Ambient)

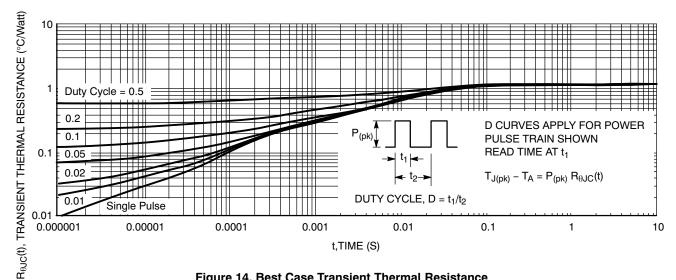
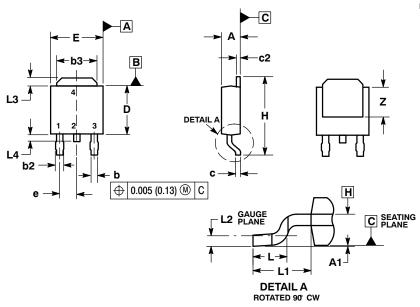


Figure 14. Best Case Transient Thermal Resistance (Non-normalized Junction-to-Case Mounted on Cold Plate)

PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE) CASE 369C ISSUE D



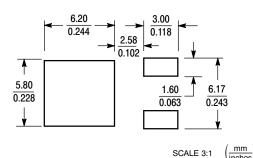
NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PI ANF H

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29	BSC	
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108	REF	2.74 REF		
L2	0.020	BSC	0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

- - 2. COLLECTOR
 - 3. EMITTER
- STYLE 7: PIN 1. GATE
 - COLLECTOR

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and un are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. arising out of the application or use of any product or circuit, and specification scan and do vary in different applications and actual performance may vary over time. All operating parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA **Phone**: 303–675–2175 or 800–344–3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your loca Sales Representative